

General Description

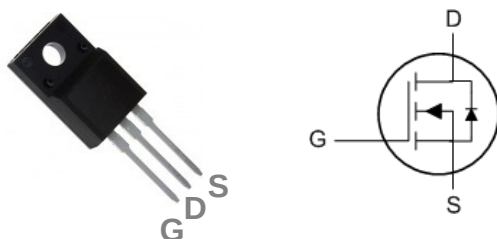
These N-Channel enhancement mode power field effect transistors are using advanced super junction technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply

BVDSS	RDSON	ID
650V	0.95Ω	12A

Features

- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

TO220F Pin Configuration



Applications

- High efficient switched mode power supplies
- TV Power
- Adapter/charger
- Server Power
- PV Inverter / UPS

Absolute Maximum Ratings $T_c=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	650	V
V_{GS}	Gate-Source Voltage	± 30	V
I_D	Drain Current – Continuous ($T_c=25^{\circ}\text{C}$)	12	A
	Drain Current – Continuous ($T_c=100^{\circ}\text{C}$)	7.6	A
I_{DM}	Drain Current – Pulsed ¹	48	A
EAS	Single Pulse Avalanche Energy ²	72	mJ
IAS	Single Pulse Avalanche Current ²	12	A
P_D	Power Dissipation ($T_c=25^{\circ}\text{C}$)	40	W
	Power Dissipation – Derate above 25°C	0.32	W/ $^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^{\circ}\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}\text{C}$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	3.1	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V$, $I_D=250\mu A$	650	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1mA$	---	0.5	---	$V/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=650V$, $V_{GS}=0V$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{DS}=520V$, $V_{GS}=0V$, $T_J=125^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 30V$, $V_{DS}=0V$	---	---	± 100	nA

On Characteristics

$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V$, $I_D=6A$	---	0.82	0.95	Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250\mu A$	3	4	5	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		---	-8	---	$mV/^\circ\text{C}$
gfs	Forward Transconductance	$V_{DS}=10V$, $I_D=2A$	---	8	---	S

Dynamic and switching Characteristics

Q_g	Total Gate Charge ^{3,4}	$V_{DS}=520V$, $V_{GS}=10V$, $I_D=2A$	---	38.5	---	nC
Q_{gs}	Gate-Source Charge ^{3,4}		---	10.7	---	
Q_{gd}	Gate-Drain Charge ^{3,4}		---	11.3	---	
$T_{d(on)}$	Turn-On Delay Time ^{3,4}	$V_{DD}=300V$, $V_{GS}=10V$, $R_G=3.3\Omega$ $I_D=1A$	---	19.3	38	ns
T_r	Rise Time ^{3,4}		---	21	42	
$T_{d(off)}$	Turn-Off Delay Time ^{3,4}		---	40	80	
T_f	Fall Time ^{3,4}		---	68	136	
C_{iss}	Input Capacitance	$V_{DS}=25V$, $V_{GS}=0V$, $F=1MHz$	---	2100	3000	pF
C_{oss}	Output Capacitance		---	120	200	
C_{rss}	Reverse Transfer Capacitance		---	12	24	
R_g	Gate resistance	$V_{GS}=0V$, $V_{DS}=0V$, $F=1MHz$	---	3.3	---	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Source Current	$V_G=V_D=0V$, Force Current	---	---	12	A
I_{SM}	Pulsed Source Current		---	---	48	A
V_{SD}	Diode Forward Voltage	$V_{GS}=0V$, $I_S=1A$, $T_J=25^\circ\text{C}$	---	---	1	V
t_{rr}	Reverse Recovery Time ³	$V_{GS}=0V$, $I_S=1A$, $dI/dt=100A/\mu s$	---	---	---	nS
Q_{rr}	Reverse Recovery Charge ³	$T_J=25^\circ\text{C}$	---	---	---	μC

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $V_{DD}=50V$, $V_{GS}=10V$, $L=1mH$, $I_{AS}=12A$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$.
3. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.

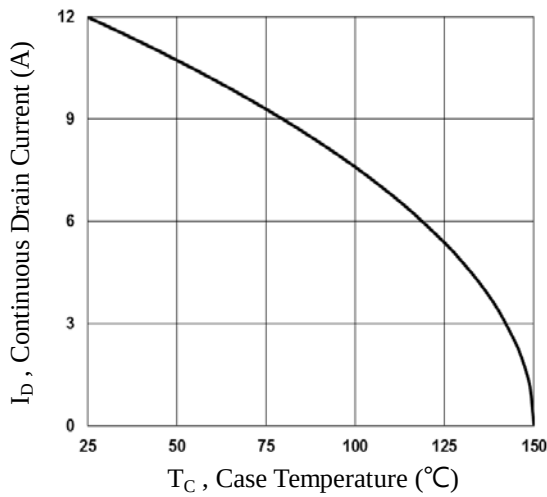


Fig.1 Continuous Drain Current vs. T_C

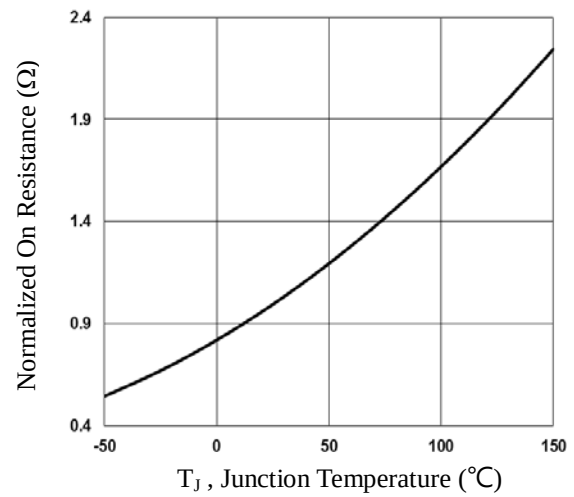


Fig.2 Normalized $R_{DS(on)}$ vs. T_J

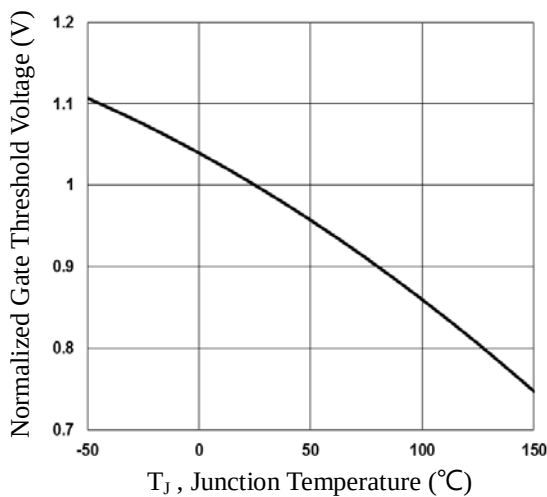


Fig.3 Normalized V_{th} vs. T_J

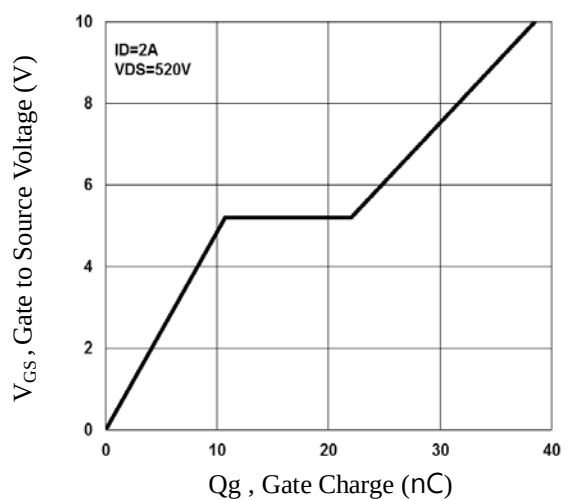


Fig.4 Gate Charge Waveform

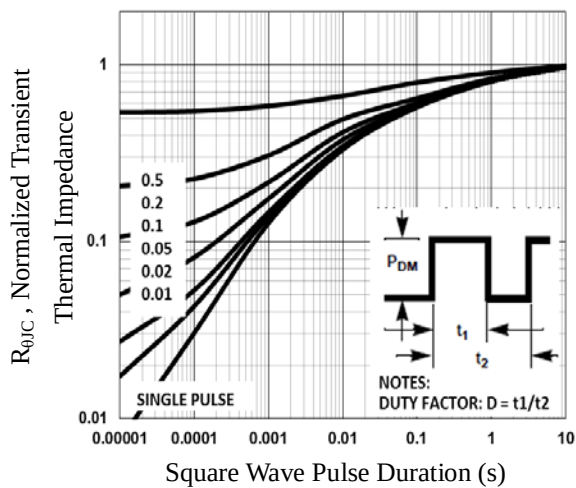


Fig.5 Normalized Transient Impedance

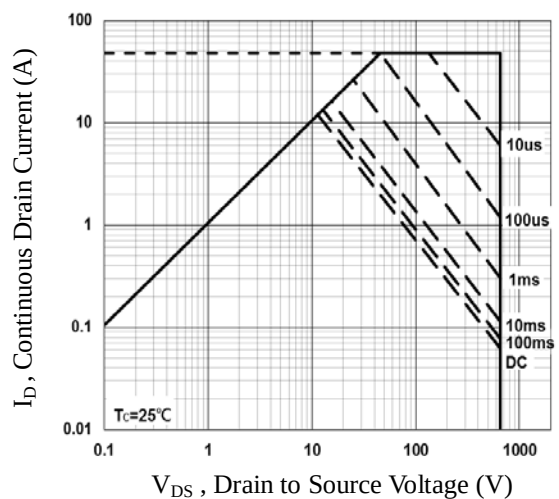


Fig.6 Maximum Safe Operation Area

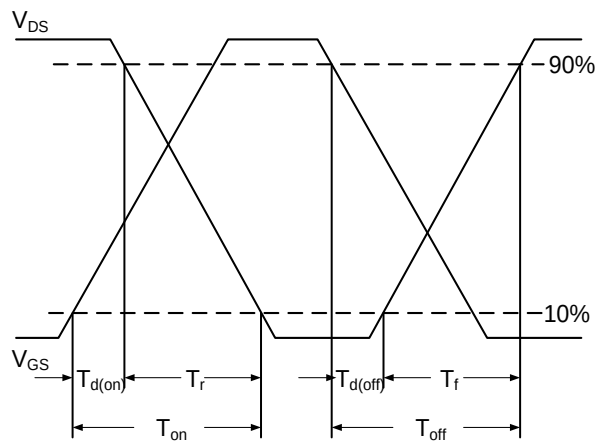


Fig.7 Switching Time Waveform

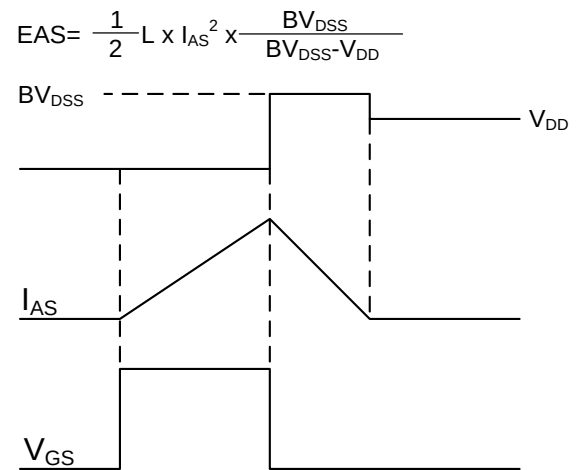
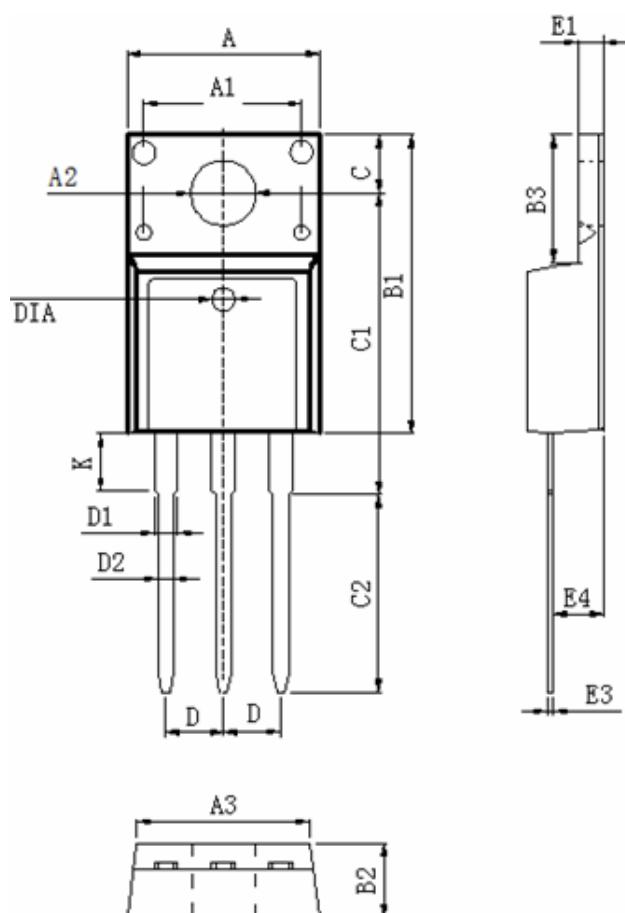


Fig.8 EAS Waveform

TO220F PACKAGE INFORMATION



DIM	MILLIMETERS
A	10.16 ± 0.3
A1	7.00 ± 0.1
A2	3.3 ± 0.2
A3	9.7 ± 0.2
B1	15.87 ± 0.3
B2	4.7 ± 0.2
B3	6.68 ± 0.2
C	3.3 ± 0.2
C1	12.57 ± 0.3
C2	12.98 ± 0.4
D	2.54 ± 0.05
D1	1.27 ± 0.2
D2	0.8 ± 0.1
K	3.1 ± 0.2
E1	2.54 ± 0.2
E3	0.5 ± 0.1
E4	2.76 ± 0.2
DIA	$\varnothing 1.5(\text{deep } 0.1)$

(Unit:mm)